Hong-Ou-Mandel microscopy

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Hong-Ou-Mandel (HOM) interference, i.e. the bunching of indistinguishable photons at a beam splitter is a staple of quantum optics and lies at the heart of many quantum sensing approaches and recent optical quantum computers. Although originally proposed as a method for sensing micron-scale variations in quantum sense states through post-selection with spatial light-modulators and single-pixel detectors, for multi-photon ghost-imaging [8, 9]. The combination of these approaches has a 1:1 mapping to coincidence rate. We spatially resolve the HOM interference across multiple spatial modes by reconstructing the two-photon spatial joint probabilistic distribution at every pixel position of a single photon avalanche diode (SPAD) camera, from which we extract the depth profile of samples such as a pattern of clear acrylic sprayed over a microscope slide with an average depth of $\sim 13 \mu m$ or a pattern etched on a glass substrate of $\sim 8 \mu m$ depth. In both cases, we observe that the depth profile of the sample is not accessible through direct intensity measurement. However, when observed with the HOM imaging system, we obtain a contrast image that does reveal the structure of the object. Image resolution is enhanced via a standard 2x2 camera raster scanning technique whilst noise in the image is reduced by combining information from both the bunched and anti-bunched photons and based on ideas recently introduced in Ref. 7. The combination of these approaches and the high frame rates of the SPAD camera, allow efficient imaging of micron-sized features at very low-photon

Introduction. The bunching of indistinguishable photons at the outputs of a beam splitter is the key signature of the Hong-Ou-Mandel (HOM) effect [1]. Since the first demonstration, this effect has found many applications in various fields of quantum optics, from quantum state engineering [2, 3], quantum information processing [4, 5] and quantum metrology [6, 7]. In the context of quantum imaging, HOM interference has been exploited to engineer quantum states through post-selection with spatial light-modulators and single-pixel detectors, for multi-photon ghost-imaging [8, 9]. The combination of these approaches has a 1:1 mapping to coincidence rate. We spatially resolve the HOM interference across multiple spatial modes by reconstructing the two-photon spatial joint probabilistic distribution at every pixel position of a single photon avalanche diode (SPAD) camera, from which we extract the depth profile of samples such as a pattern of clear acrylic sprayed over a microscope slide with an average depth of $\sim 13 \mu m$ or a pattern etched on a glass substrate of $\sim 8 \mu m$ depth. In both cases, we observe that the depth profile of the sample is not accessible through direct intensity measurement. However, when observed with the HOM imaging system, we obtain a contrast image that does reveal the structure of the object. Image resolution is enhanced via a standard 2x2 camera raster scanning technique whilst noise in the image is reduced by combining information from both the bunched and anti-bunched photons and based on ideas recently introduced in Ref. 7. The combination of these approaches and the high frame rates of the SPAD camera, allow efficient imaging of micron-sized features at very low-photon
FIG. 1. **Principles of Hong-Ou-Mandel imaging.** a. In a Hong-Ou-Mandel interferometer, the paths of two indistinguishable photons, signal and idler, overlap on a 50/50 beamsplitter. The signal photon traverses a transparent sample of varying thickness, and the outputs of the beam-splitter are, colour-wise, measured in coincidences. b. When adjusting the idler delay to the reference position (dashed line), the three paths map different coincidence probabilities, allowing one to obtain a contrast image of the transparent sample for a range of depths indicated by the shaded area. This can be used to reconstruct the depth thickness variation across the sample.

**Concept.** The idea behind our Hong-Ou-Mandel imaging technique is shown in Fig. 1. The paths of two indistinguishable photons are overlapped onto a 50/50 beamsplitter. A (signal) photon travels through a sample with a varying thickness, while the other (idler) photon does not. For each of the three colour-coded trajectories, the signal photon incurs different group velocity delays, leading to different arrival times with respect to the idler photon on the matching trajectory. Coincidence measurements on each of the colour-coded paths at the outputs of the beamsplitter, show that the two-photon interference signals are shifted with respect to each other. By recording the coincidence rates in each of the colour-coded paths, one can obtain a contrast image of the sample.

**Experimental setup.** The layout of the HOM imaging system is depicted in Fig. 2a (See Methods for full details). Signal and idler photon pairs are generated via spontaneous parametric down-conversion and are spatially separated in the far-field using a D-shaped mirror. Both signal and idler propagate through identical 4f imaging systems that relay the far-field to planes P1 and P2 – the sample to be imaged is placed in P2. The image of planes P1 and P2 are overlapped using a 50:50 beam-splitter (BS) and imaged, using identical imaging systems onto a SPAD camera (SPC3 from MPD) with an array of 32 × 64 pixels, an 80% fill-factor and a 150-µm pixel pitch that can acquire up to 96 kframes/second. The two outputs from the BS are shown in (Fig. 2b), where pixel positions A(B) and A'(B') map to photon paths in the two outputs of the BS. In the event of bunching, pairs of photons would be detected at either A(B) or A'(B'). Meanwhile in the event of anti-bunching, one photon in a pair would be detected at A(B) and the other at A'(B). By applying a π-rotation on one of the output arms, we note that spatially correlated pair-detection is indicative of bunching, while spatially anti-correlated pair-detection indicates anti-bunching.
FIG. 3. Hong-Ou-Mandel sensing with a SPAD camera. Following the reconstruction of the two-photon spatial distribution, its projection onto the a sum-coordinates reveals a correlation peak corresponding to the numbers of photons measured at anti-correlated positions (anti-bunching). b Similarly, the projection onto the minus-coordinates evaluates the number of photons bunching. The fraction of photons bunching can be evaluated by either fitting a peak, or measuring the signal from adjacent pixels. c By scanning the delay stage, we measure the Hong-Ou-Mandel interference. The legend indicates the anti-bunching results (HOM interference dip) and the bunching results (HOM interference peak) under the two approximations tested (error bars are the same size or smaller than dots). At each delay position, we acquire and analyse on average 19 million intensity frames. d HOM interference visibility versus focal length of the pump focusing lens. The highest visibility is observed when the pump is focused such that the two-photon correlation width is equal to the camera pixel pitch. The insets show the normalised sum-coordinate projections of the JPD for different pump lens focal lengths (plotted over 10x10 pixels).

The probability distribution (JPD), $\Gamma(r_s, r_i)$, using the following model [32]:

$$\Gamma(r_s, r_i) = \frac{1}{N} \sum_{l=1}^{N} I_l(r_s)I_l(r_i) - \frac{1}{N^2} \sum_{m,n=1}^{N} I_m(r_s)I_n(r_i),$$

(1)

where $I_l(r) \in \{0,1\}$ is the binary value returned by the SPAD sensor for a pixel at location $r$ in the $l^{th}$ frame. Over the acquisition time of the camera, set here to 10 $\mu$s, the sensor may measure photons from multiple pairs. The intra-frame correlation in Eq. (1) (first term on the right-hand side) estimates the number of coincidences from photons belonging to the same pair (genuine coincidences), as well as those from different pairs (accidental coincidences). The latter are estimated and removed from the reconstructed JPD by subtracting the inter-frame correlations (second term on the right-hand side).

As highlighted above in the experimental configuration, anti-bunching events are registered as pair-detections from spatially anti-correlated photons and are estimated by projecting the JPD onto the sum-coordinates, Fig. 3a. The height of the measured correlation peak indicates the number of reconstructed anti-bunching events. The number of bunching events can be extracted from pair-detections of spatially correlated photons, i.e. we project the JPD onto the minus-coordinates as show in Fig. 3b. In this case, we do not have a correlation peak because the pixels on the SPAD camera are not able to photon-number-resolve. Therefore, it is not possible to directly measure events of two photons incident on the same pixel.

We then characterised the HOM dip (peak) from two-photon interference by scanning the signal arm delay stage and evaluated the number of anti-bunching and bunching events at each pixel, as shown in Fig. 3c and obtain a HOM dip with a visibility of 88 ± 2% (red circles). To then estimate the number of bunching events, we can either fit a Gaussian peak to estimate the correlation amplitude of the central pixel (blue circles, 81 ± 7% visibility) or simply average over the four nearest neighbours to the central pixel (black circles, 60 ± 7%). The latter has lower visibility as one may expect but was the preferred option in the following results as it

FIG. 4. Full-field Hong-Ou-Mandel sensing. 32x32 pixel spatial images of photon coincidences arising from bunching and anti-bunching, reconstructed as a function of spatial delay between signal and idler photons. The bunching images are obtained by measuring coincidences across adjacent pixels. At each delay position, the two-photon distribution is reconstructed from an average of 19 million intensity frames.
FIG. 5. **Full-field Hong-Ou-Mandel imaging.** a The intensity image as captured by the SPAD camera of a clear acrylic cross-pattern on a microscope slide. b Shows the bunching (from adjacent pixels) and c anti-bunching coincidence maps. The inset to b shows an image of the sample and the profile measurement taken along the yellow dashed line - average height is 12.9 µm. d The number of coincidence events is converted to a height measurement relative to the surface of the microscope slide. e The combination of weighted bunching and anti-bunching images produces a normalised image with reduced noise. f Intensity image of the letters ‘UofG’ etched into a glass substrate, to a depth of 8.36 µm. g Shows the anti-bunching (from adjacent pixels) at the native 32x32 camera resolution and h is 64x64 pixel super-resolved image obtained by 2x2-raster scanning the camera. The inset to g shows an image of the sample and the profile measurement taken along the yellow dashed line. i Depth map of the sample obtained from the coincidence map in h. j The combination of weighted bunching and anti-bunching images produces a normalised image with reduced noise.

relies only on measured data (see Methods).

**Tailoring the two-photon correlation.** The spatial width of the two-photon correlation provides a measurement of the average mode width and plays a key role in optimising the HOM visibility measured by the camera. The correlation width can be controlled by the pump diameter as this will determine the number of modes and the divergence (k-vector spectrum) of the SPDC. Figure 3d shows the measured HOM dip visibility as we vary the pump beam diameter on the SPDC crystal by changing the pump beam focusing lens, $f_0$. If the correlation width is much smaller than the camera pixel pitch (large focal lengths, loose pump focusing), then many modes will overlap at the same pixel. If the correlation width is very broad (short focal length, tight pump focusing) then each single mode spreads across many pixels and will overlap with other modes. In both cases, HOM visibility is lost. Instead, the highest HOM interference visibility is obtained when each pixel acts a single mode detector, i.e. when the correlation width is of the same order of the camera pixel size of 150 µm (in our case, this corresponds to $f_0 = 300$ mm).

**Full-field Hong-Ou-Mandel interferometry.** Figure 4 shows the spatially resolved bunching and anti-bunching coincidence maps for 5 different delays over one half of the sensor, the other half simply being a symmetric image and which contains the same information. As the interferometer spatial delay tends to zero, the number of bunching events increases to a maximum, while the anti-bunching events tend to zero. Crucial to our HOM imaging technique, this full-field HOM measurement shows the direct pixel-wise-resolved mapping between spatial delay and number of coincidence events.

**Hong-Ou-Mandel imaging.** A first sample was prepared by spraying a layer of clear acrylic on a glass substrate forming a cross-pattern with a depth of 12.9 µm, averaged along the dashed line (inset above Fig. 5a), as measured with a profilometer. Figure 5a shows the intensity (photon counts) image as recorded by the SPAD camera. The sample itself, as expected, is not visible although the edges are barely visible likely due to scattering that leads to an effective loss. The HOM images are extracted from the JPDs reconstructed from a total of 130 million intensity frames (total acquisition time of 37 minutes) and are shown in Figs. 5b and 5c, for the bunching and anti-bunching coincidence events respectively. These images show a clear contrast between the acrylic surface and its surroundings.
anti-bunching and bunching images that appear as contrast reverse images of each other, due to conservation of probability (i.e. with small discrepancies due to noise and any losses).

We use the spatially resolved coincidence counts resolved versus delay in 4 μm steps (of which 5 delays are shown in Fig. 4) as a depth estimator and obtain from Fig. 5c, the relative depth profile of the sample shown in Fig. 5e. From this, we estimate the average thickness of the layer of acrylic to be 14.5 ± 6 μm, in relatively good agreement with the ground truth measured value. We note the large error (standard deviation) around the average value that is due to the fact that the sample itself is not uniform but also due to the obvious noise in images. However, recent work showed that photon number resolving information can increase precision in (lossy) conventional HOM sensing by combining bunching and anti-bunching signals [7] (see Methods). A significantly improved image is then retrieved, Fig. 5f, which has a variance that is 3.4x smaller compared to the direct measurement Fig. 5c: in the cross region of the image.

A second sample was fabricated by etching the letters ‘UofG’ onto a glass substrate to a depth of 8.36 μm (measured with a profilometer, inset to Fig. 5g showing also profile along the yellow dashed line) and width of the lettering etch, 230 μm. Figure 5g shows the intensity image that does not reveal any details about the shape of the etched sample. Figure 5h shows the anti-bunching coincidence image at the camera native 32x32 pixel resolution. The ‘UofG’ pattern is visible but is strongly under-resolved. We therefore also performed a 2x2 raster scan of the camera so as to increase the pixel resolution by a factor 4x (by simple ‘shift and add’ of the four raster-scan images [33]): the sample is now clearly visible in the anti-bunching HOM image in Fig. 5h. We also observe high counts at the edges of the etched regions. This is due to the very sharp profile of the etching (compared to the relatively smooth edges of the acrylic sample) that leads to edge-diffraction along the contours of the letters. This diffraction introduces additional transverse wave-vector components on the transmitted photons, which reduces the indistinguishability between signal and idler photons and a higher coincidence rate with respect to the surrounding non-etched parts. Figure 5i shows the retrieved depth image from the high-resolution coincidence image from which we estimate an etching depth of 8.2 ± 1.2 μm, in very good agreement with the ground truth reference measurement and also shows a relatively low error that is in line with typical HOM measurements that use single point detection. As for the case of the cross, a weighted combination of the bunching and anti-bunching data has a reduced noise with a reduced variance of 1.6x inside the letters (Fig. 5i).

Conclusions. HOM interference can be used in full-field imaging to directly retrieve spatially-resolved depth profiles of transparent samples. Access to both bunching and anti-bunching images can be used to also assess losses and in turn reduce the noise variance in the images by up to nearly an order of magnitude in the best case.

To put these measurements into context, we note that the average coincidence values are of order 1 Hz/pixel, which at 60 kframes/second implies roughly only 1 frame every 60 detecting an actual photon pair. If we consider the camera photon detection probability (80% fill factor and 6% quantum efficiency), this corresponds to an actual average photon pair flux in the interferometer of ∼ 400 photon pairs/pixel/second or ∼ 7 photon pairs/frame. This is extremely low yet this still allows us to retrieve clear images with μm-level absolute precision in the depth measurements.

Photon density and total illumination on the sample are also often quoted as a concern for some bio-imaging applications. The results shown here were performed in a regime in which ∼ 10^5 photons/pixel are required to illuminate the sample for the total minimum exposure time of ∼ 20 minutes (if running the camera at 96 kframes/second). This can be possibly be further reduced by more than order of magnitude by improving the camera technology as indeed, photon pair detection scales quadratically with the camera quantum efficiency. HOM imaging therefore provides an opportunity for example for label-free bio-imaging with very low photon fluxes. Beyond these applications, the methods demonstrated here can be transferred e.g. to quantum optical coherence tomography that essentially also leverages photon bunching to detect multiple interfaces and layered structures.

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METHODS

Experimental layout. Signal and idler photon pairs are generated via type-I spontaneous parametric down-conversion (SPDC) in a 0.5-mm long β-barium borate (BBO) crystal. The generated photons are
spatially separated in the far-field of the BBO crystal using a D-shaped mirror. The signal photon travels through a delay line where the path length can be adjusted using a motorised translation stage. The idler photon travels through a fixed length path where a dove prism performs an image inversion in the transverse plane. Both signal and idler propagate through identical 4f-imaging systems that relay the far-field of the BBO crystal (image plane of the D-shaped mirror) to planes P1 and P2 – the sample to be imaged will subsequently be placed in the latter plane. The image of planes P1 and P2 are overlapped using a 50:50 beam-splitter (BS) and imaged, using identical imaging systems in both output ports, onto a SPAD camera (SPC3 from MPD) with an array of 32 × 64 pixels, an 80% fill-factor and a 150-μm pixel pitch. The camera has a quantum efficiency of ∼9% at the photon pair wavelength (694 nm), a nominal frame-rate of 96 kframes/second and a dark-count rate of 0.14 counts/pixel/second. For most of the experiments, the camera was operated at 60 kframes/second due to software/computer limitations.

**Joint Probability Distribution measurements.** At each delay position, we reconstructed the JPD from a total of 19 million intensity frames and measured a HOM dip with a visibility of 88 ± 2%. To then estimate the number of bunching events, we used two approaches. The first consists in fitting a Gaussian peak to the minus-coordinates projection and use the peak as the estimate. Using this approach, we measured a HOM dip with a visibility of 88 ± 9%, comparable to that obtained for HOM dip. The second approach exploits the fact that (i) the two-photon correlation width is larger than one pixel and (ii) the SPAD camera has a relatively high fill-factor (80%). Thus, we can estimate the number of bunching events where photons are incident on adjacent pixels, i.e. coincidences are generated from the conditional distribution $\Gamma(\mathbf{r}|\mathbf{r} + \Delta \mathbf{r})$, where $\Delta \mathbf{r}$ is a transverse shift by a single pixel and averaged over the four nearest neighbour pixels. The visibility measured in this case is 60 ± 7%. This lower value is to be expected given that adjacent pixels capture different spatial modes, thus increasing photon distinguishability.

**Photon number resolution approach for improved signal to noise.** In the presence of photon loss (or detectors with limited efficiency), distinguishing single-photon clicks from bunching and coincidence events can increase the precision of HOM-based sensing [7]. The HOM signal is not constrained to the anti-diagonal ($k_x = -k_x$) of the JPD which indicates coincidence between a pixel and its coincidence partner; additional coincidence and bunching information is found through the JPD terms correlating a pixel with neighbours of itself and of its coincidence partner (the non-zero values of the sum and minus coordinates shown in Fig. 3) that arise due to a correlation point-spread function which, although matched to the pixel size as described in the main text, will spread across adjacent pixels due to its Gaussian-like distribution. These latter terms allow us to harness the number-resolving advantage in the fundamental HOM experiment [2] as well as addressing array-specific noise contributions [26]. In order to account for different quality dips across the images we rescale the images based on image regions of constant coincidence counts. For example, we select with a mask, the inner or the outer regions of the cross and the inner or outer regions of the ‘UofG’ lettering. These rescaled images are then combined according to the estimator for a common signal in multiple independent noisy channels—$\hat{\theta} = [\sum_j \sigma_j \sum_j (x_j/\sigma_j)]$—to obtain a minimum-variance estimate [31]. Here, $j$ denotes the anti-bunching and bunching images that are therefore summed together with relative weights given by the $\sigma_j$ values, i.e. the associated standard deviation in the counts that are used as a noise estimate and are computed in an image region of constant coincidence counts.

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